# DISCRETE SEMICONDUCTORS

# DATA SHEET

# **BLV91/SL**UHF power transistor

**Product specification** 

September 1988





BLV91/SL

#### **DESCRIPTION**

NPN silicon planar epitaxial transistor designed for use in mobile radio transmitters in the 900 MHz band.

#### **FEATURES**

- diffused emitter-ballasting resistors for an optimum temperature profile.
- gold metallization ensures excellent reliability.
- the device can be applied at rated load power, without an external heatsink, when it is mounted on a printed-circuit board (see Fig.6).

The transistor has a 4-lead envelope with a ceramic cap (SOT-172D). All leads are isolated from the mounting base.

#### **QUICK REFERENCE DATA**

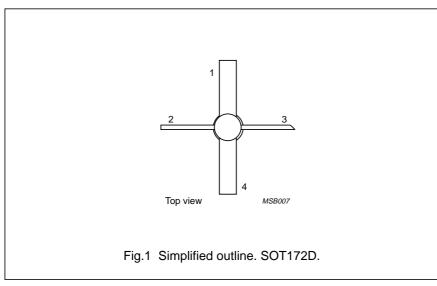
RF performance in a common-emitter class-B circuit

MODE OF OPERATION	T °C	V <sub>CE</sub> V	f MHz	P <sub>L</sub> W	G <sub>p</sub> dB	η <b>с</b> %
narrow band; CW	$T_{mb} = 25$	12.5	900	2	> 6.5	> 50
	$T_a = 25^{(1)}$	12.5	900	1.5	> 6.5	> 50
	$T_a = 25^{(1)}$	9.6	900	1.5	typ. 6.6	typ. 60

#### Note

1. Device mounted on a printed-circuit board (see Fig.6).

## **PIN CONFIGURATION**



## PINNING - SOT172D.

PIN	DESCRIPTION
1	emitter
2	base
3	collector
4	emitter

PRODUCT SAFETY This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

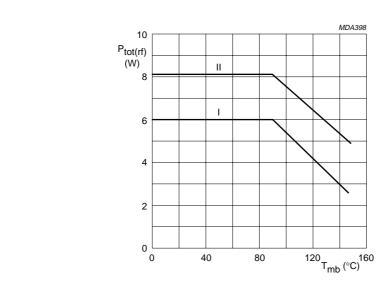
# **UHF** power transistor

BLV91/SL

#### **RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3	V
Collector current				
DC or average	I <sub>C</sub> ; I <sub>C(AV)</sub>	max.	0.4	Α
(peak value); f > 1 MHz	I <sub>CM</sub>	max.	1.2	Α
Total power dissipation				
$f > 1 \text{ MHz}; T_{mb} \le 90 ^{\circ}\text{C}$	$P_{tot(RF)}$	max.	6	W
Storage temperature	$T_{stg}$	-65 to -	+ 150	°C
Operating junction temperature	T <sub>i</sub>	max.	200	°С



- I Continuous RF operation (f > 1 MHz)
- II Short-time RF operation during mismatch (f > 1 MHz)

Fig.2 Power/temperature curve.

# THERMAL RESISTANCE

Dissipation = 4.5 W

From junction to ambient<sup>(1)</sup> (f > 1 MHz)

 $T_a = 25 \, ^{\circ}\text{C}$   $R_{th j-a \, (RF)}$  max. 55 K/W

From junction to mounting base

 $T_{mb} = 25 \, ^{\circ}\text{C (f} > 1 \, \text{MHz}) \qquad \qquad \qquad 15 \, \text{ K/W}$ 

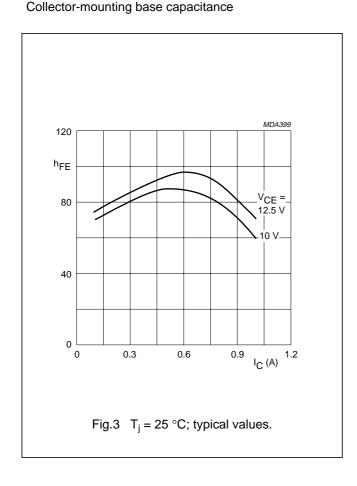
# Note

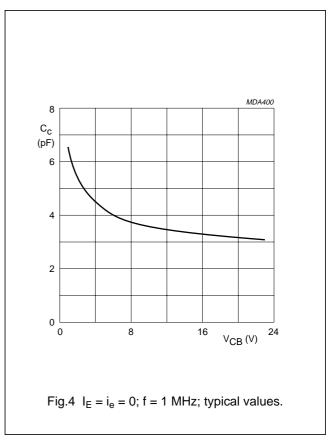
1. Device mounted on a printed-circuit board (see Fig.6).

BLV91/SL

#### **CHARACTERISTICS**

T<sub>i</sub> = 25 °C unless otherwise specified Collector-base breakdown voltage open emitter;  $I_C = 5 \text{ mA}$  $V_{(BR)CBO}$ 36 V Collector-emitter breakdown voltage 16 V open base; I<sub>C</sub> = 10 mA  $V_{(BR)CEO}$ Emitter-base breakdown voltage open collector; I<sub>E</sub> = 0.5 mA 3 V  $V_{(BR)EBO}$ Collector cut-off current  $V_{BE} = 0; V_{CE} = 16 \text{ V}$ 2.5 mA I<sub>CES</sub> < Second breakdown energy L = 25 mH; f = 50 Hz;  $R_{BE} = 10~\Omega$ 0.55 mJ **E**SBR D.C. current gain  $I_C = 0.3 A$ ;  $V_{CE} = 10 V$ 25  $h_{\mathsf{FE}}$ Collector capacitance at f = 1 MHz  $I_E = i_e = 0$ ;  $V_{CB} = 12.5 \text{ V}$  $C_{C}$ 3.5 pF typ. Feedback capacitance at f = 1 MHz 2.0 pF  $I_C = 0$ ;  $V_{CE} = 12.5 \text{ V}$  $C_{re}$ typ.





typ.

0.5 pF

 $C_{c-mb}$ 

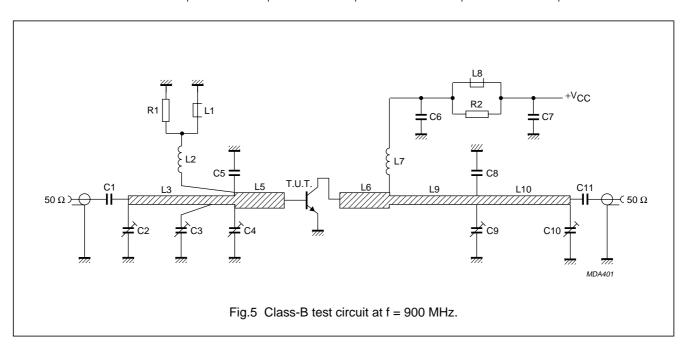
# **UHF** power transistor

BLV91/SL

# **APPLICATION INFORMATION**

RF performance in CW operation (common-emitter circuit; class-B): f = 900 MHz

MODE OF OPERATION	V <sub>CE</sub> V	P <sub>L</sub> W	G <sub>p</sub> dB	η <b>c</b> %	T °C
narrow band; CW	12.5	2	> 6.5	> 50	T <sub>mb</sub> = 25
	12.5	2	typ. 7.8	typ. 60	$T_{mb} = 25$
	12.5	1.5	> 6.5	> 50	$T_a = 25^{(2)}$
	9.6	1.5	typ. 6.6	typ. 60	$T_a = 25^{(2)}$



# **UHF** power transistor

BLV91/SL

#### List of components:

C1 = C11 = 33 pF multilayer ceramic chip capacitor

C2 = C3 = C10 = 1.4 to 5.5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C4 = C5 = 5.6 pF multilayer ceramic chip capacitor (1)

C6 = 10 pF multilayer ceramic chip capacitor

C7 = 330 pF multilayer ceramic chip capacitor

C8 = 3.9 pF multilayer ceramic chip capacitor(1)

C9 = 1.2 to 3.5 pF film dielectric trimmer (cat. no. 2222 809 05001)

L1 = L8 = Ferroxcube wideband HF choke, grade 3B (cat. no. 4312 020 36642)

L2 = 60 nH; 4 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads  $2 \times 5$  mm

L3 = 50  $\Omega$  stripline (25.4 mm  $\times$  2.4 mm)

L4 = 50  $\Omega$  stripline (4.4 mm  $\times$  2.4 mm)

L5 = L6 = 34  $\Omega$  stripline (14.0 mm  $\times$  4.0 mm)

L7 = 280 nH; 15 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads  $2 \times 5$  mm

L9 = 50  $\Omega$  stripline (24.8 mm  $\times$  2.4 mm)

L10 = 50  $\Omega$  stripline (30.5 mm  $\times$  2.4 mm)

R1 = R2 = 10  $\Omega \pm 5\%$ ; 0.25 W metal film resistor

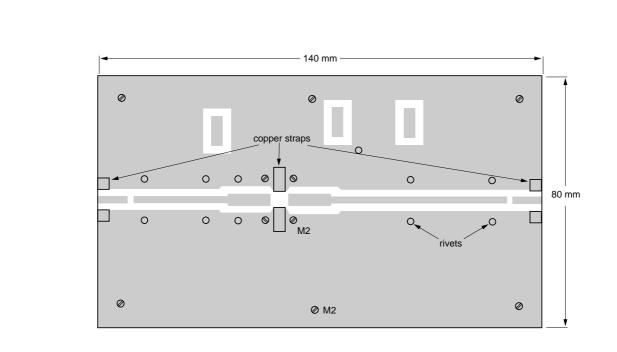
L3, L4, L5, L6, L9 and L10 are striplines on a double Cu-clad printed-circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness  $^{1}$ /<sub>32</sub> inch; thickness of copper-sheet 2 × 35  $\mu$ m.

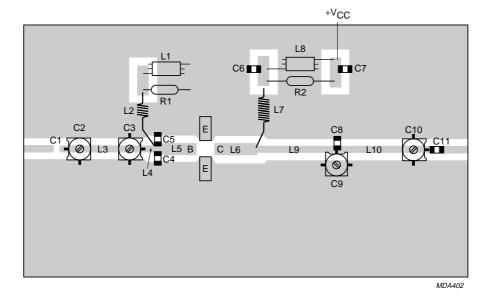
## Notes

- 1. American Technical Ceramics capacitor type 100A or capacitor of same quality.
- 2. Device mounted on a printed-circuit board (see Fig.6).

# **UHF** power transistor

# BLV91/SL



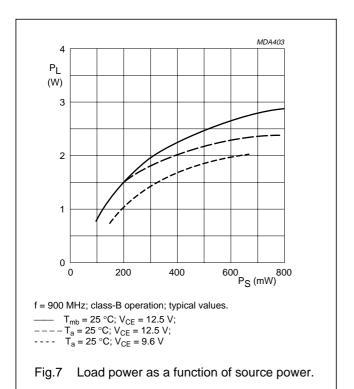


The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as groundplane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the groundplane.

Fig.6 Printed-circuit board and component lay-out for 900 MHz class-B test circuit.

# **UHF** power transistor

BLV91/SL



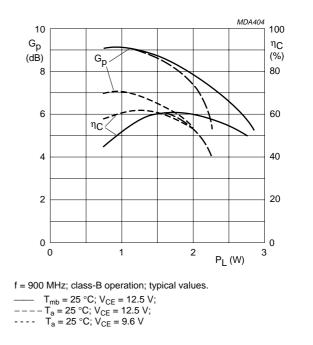
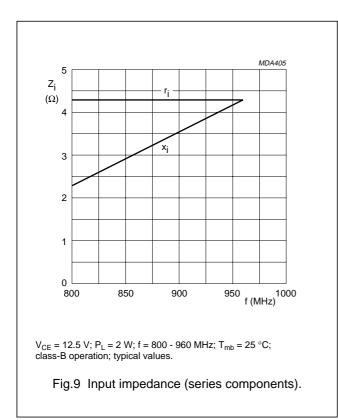


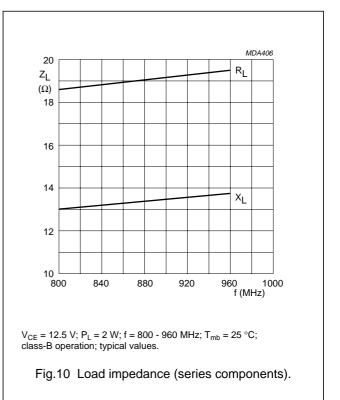
Fig.8 Power gain and efficiency as a function of load power.

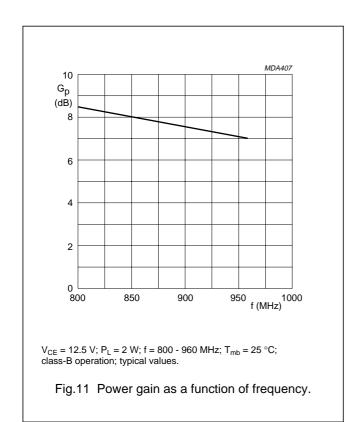
## **RUGGEDNESS**

The device is capable to withstand a full load mismatch (VSWR = 50; all phases) at  $P_L$  = 1.5 W up to a supply voltage of 15.5 V at  $T_a$  = 25 °C. Device mounted on a printed-circuit board (see Fig.6).

BLV91/SL





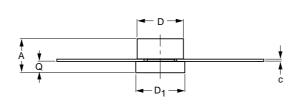


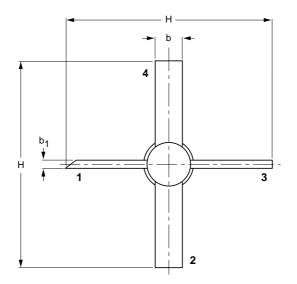
BLV91/SL

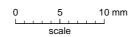
# **PACKAGE OUTLINE**

Studless ceramic package; 4 leads

SOT172D







# DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	b <sub>1</sub>	С	D	D <sub>1</sub>	н	Q
mm	3.71 2.89	3.31 3.04	0.89 0.63	0.16 0.10	5.20 4.95	5.33 5.08	26.17 24.63	1.15 0.88
inches	0.146 0.114	0.13 0.12	0.035 0.025		0.205 0.195	0.210 0.200		0.045 0.035

OUTLINE		REFER	ENCES	EUROPEAN ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT172D					97-06-28	

# **UHF** power transistor

BLV91/SL

#### **DEFINITIONS**

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	

#### Limiting values

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

#### **Application information**

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.